

Application/Control No.	Applicant(s)/Pate	nt Under	
09/941,409	Reexamination SUGAYA ET AL.		
Examiner	Art Unit	<u> </u>	
Ly T TRAN	2853	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4597794	07-1986	Ahta et al	106/20
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
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	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

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	N	0564420	10-1993	EP	Endo et al	
	0	05-112000	05-1993	JP	Okobo et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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